

Compatible to WEEE and RoHS directives

Compatible to Green Procurement

Simple Analysis of such hazardous metals as Pb and Cd at ppm order



No liquid nitrogen required

SEA1000A II

Energy Dispersive Fluorescent X-ray Analyzer

HS (Hazardous Substance) Monitor

Reduced detector running costs since no liquid nitrogen is required.

Inexpensive

Fast

High counting circuit for shorter measurement times.



Important products can be measured non-destructively in the large chamber.

Large chamber

Simple

Measuring is easy with auto-correction software that minimizes effects from sample shape, thickness, and material.

ely 370(15")(W)X320(13")(D) X 155(6")(H)mm

Measurement data can be easily sent to a Word® format. Measurement results, spectral data, and sample images can be simultaneously sent.

Measurement data can be automatically sent and saved in an Excel® worksheet.

Plastic standards and film thickness standards.

<http://www.siint.com>

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